DOCUMENT CHANGE REQUEST

DCR number 539	Changes required for: General	Originator: S Jeffery - ESCC
Date: 2009/08/18	Date sent: 2009/08/18	Organisation: ESA/ESTEC
Status: IMPLEMENTED		

Title:	Generic Specification for Attenuators and Loads RF Coaxial Fixed		
Number:	3403	Issue:	2

Other documents affected:

Page:

Specification 3403 Issue 2 is re-written as Issue 3 to incorporate changes as summarised herein (see attached for proposed Issue 3).

Paragraph:

Specification 3403 Issue 2 is re-written as Issue 3 to incorporate changes as summarised herein (see attached for proposed Issue 3).

Original wording:

Proposed wording:

Specification is amended to incorporate various editorial amendments and corrections to bring all ESCC generic specifications (that have been converted to the new ESCC format) in line with each other (i.e. ESCC 9000, 5000, 5010, 9020, 4001, 4008, 4009 and 3403).

The content of this DCR amends the editorial content of ESCC 3403 to make it consistent with published ESCC 5000 Issue 4 (ref. approved DCR 399).

These editorial changes are as follows:-

(1) Global editorial change affecting Paras. 2.2, 8.4, 8.9.2, 8.10.2, 8.11.1, 8.12 and 8.22
- Changes due to the updating of IEC Publication No. 68 to 60068.

(2) Para. 1.2 APPLICABILITY
- Amended from "This specification is primarily applicable to the granting of qualification approval to a component in accordance with ESCC Basic Specification No. 20100 and the procurement of such components from qualified Manufacturers. It may also be applied for procurement of unqualified components." to:

This specification is primarily applicable to the granting of qualification approval to components qualified in accordance with one of the following ESCC methods:

- Qualification of Standard Components per ESCC Basic Specification No. 20100.
- Technology Flow Qualification per ESCC Basic Specification No. 25400.

It is also primarily applicable to the procurement of components so qualified.

This specification may also be applied to the procurement of unqualified components, recommendations for which are given in ESCC Basic Specification No. 23100.
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(3) Para. 2.1 (APPLICABLE DOCUMENTS) ESCC SPECIFICATIONS
- Two new ESCC Detail Specifications added: "No. 23100, Recommendations on the use of the ESCC Specification System for the Evaluation and Procurement of Unqualified Components." and " No. 25400, Requirements for the Technology Flow Qualification of Electronic Components for Space Application.".

- First subparagraph changed from "...Basic Specifications Nos. 20100, 21700, 22800, and 24600, where..." to "...Basic Specifications Nos. 20100, 21700, 22800, 24600 and 25400, where...".

(4) Para. 2.2 (APPLICABLE DOCUMENTS) OTHER (REFERENCE) DOCUMENTS and Para. 4.5 MATERIALS AND FINISHES
- The ECSS specification reference has been updated to ECSS-Q-ST-70-02.

- The title of the ECSS specification has been corrected (applies to Para. 2.2 only).

(5) Para. 4.1 (REQUIREMENTS) GENERAL
- The wording has been changed from:

The test requirements for the component type qualification of a component shall comprise Special In-Process Controls, Screening Tests and Component Type Qualification Testing.

The test requirements for procurement of components shall comprise Special In-Process Controls, Screening Tests, together with Periodic Testing for qualified components and Lot Validation Testing for qualified (if required in the Purchase Order) and unqualified components.
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to:

The requirements for the qualification of a component shall be in accordance with ESCC Basic Specification No. 20100.

The requirements for Technology Flow Qualification and the listing of qualified component types shall be in accordance with ESCC Basic Specification No. 25400.

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The test requirements for procurement of both qualified and unqualified components (see Chart F1) shall comprise:

- Special In-Process Controls.
- Screening Tests.
- Periodic Testing (for qualified components only).
- Lot Validation Testing if stipulated in the Purchase Order.

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(6) Para. 4.1.4 Inspection Rights
- Amended from "...(for procurement of unqualified components) reserves..." to "...(for procurement of unqualified components if stipulated in the Purchase Order) reserves...".

(7) Para. 4.1.5 Pre-encapsulation Witnessing and Para. 5.2.3 Pre-encapsulation Inspection
- The name of the test in the titles, and where it appears in the body text of these paragraphs, has been changed from "Pre-encapsulation Inspection" to "Pre-Encapsulation Inspection".

(8) Para. 4.2 QUALIFICATION AND QUALIFICATION MAINTENANCE REQUIREMENTS ON A MANUFACTURER
- "component type" deleted from first sentence and new subparagraph "To obtain and maintain the qualification of a component produced using a qualified Technology Flow, a Manufacturer shall satisfy the requirements of ESCC Basic Specification No. 25400." added.

(9) Para. 4.3 DELIVERABLE DOCUMENTS - existing wording deleted and subparagraphs 4.3.1, ESCC Qualified Components and 4.3.2, ESCC Components added.
- The existing wording:

Components delivered to this specification shall be processed and inspected in accordance with the relevant Process Identification Document (PID). Each delivered component shall be traceable to its production lot. Components delivered to this specification shall have satisfactorily completed all the required tests.

ESCC qualified components delivered to this specification shall be produced from lots that are capable of passing all applicable tests, and sequences of tests, that are defined in Chart F4. The Manufacturer shall not knowingly supply components that cannot meet this requirement. In the event that, subsequent to delivery and prior to operational use, a component is found to be in a condition such that, demonstrably, it could not have passed these tests at the time of manufacture, this shall be grounds for rejection of the delivered lot.

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has been deleted and two new paragraphs added:

4.3.1 ESCC Qualified Components
Components delivered to this specification shall be processed and inspected in accordance with the relevant Process

Identification Document (PID).

4.3.2 ESCC Components
Each component, irrespective of qualification status, identified with an ESCC component number and delivered to this specification shall:

- be traceable to its production lot.
- have satisfactorily completed all the tests required by the relevant issues of the applicable specifications.
- be produced from lots that are considered by the Manufacturer to be capable of passing all applicable tests, and sequences of tests, that are defined in Chart F4. The Manufacturer shall not knowingly supply components that cannot meet this requirement. In the event that, subsequent to delivery and prior to operational use, a component is found to be in a condition such that, demonstrably, it could not have passed these tests at the time of manufacture, this shall be grounds for rejection of the delivered lot.

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(10) Para. 4.3.1 Lot Failure
- Re-numbered 4.3.3.

- Last sentence of second subparagraph amended from "No further testing shall be performed on the failed components." to "No further testing or analysis shall be performed on the failed components until so instructed by the ESCC Executive.".

- Penultimate sentence of third subparagraph amended from "No further testing shall be performed on the failed components." to "No further testing or analysis shall be performed on the failed components until so instructed by the Orderer.".

(11) Para. 4.5 MATERIALS AND FINISHES
- Wording of the last sentence has been amended from "...materials and finishes, that are not within a hermetically sealed enclosure, of the components..." to "...materials and finishes of the components...".

(12) Para. 5.1 (PRODUCTION CONTROL) GENERAL
- The first sentence "The minimum requirements for production control are defined in the Process Identification Document (PID)." has been deleted and a new final sentence "For qualified components the full production control provisions are defined in the PID." added.

- Second (now initial) sentence, "herein or" added between "specified" and "in" and new wording "in the sequence shown" added at the end of this sentence.

(13) Para. 5.2.4 Dimension Check
- This paragraph now begins "Dimension Check shall be performed...".

- Second sentence, "If a failure occurs, the complete lot shall be checked." has been replaced by "In the event of any failure a 100% Dimension Check shall be performed.".

(14) Para. 6.1 (SCREENING TESTS) GENERAL
- The wording of the first sentence has changed from:

Unless otherwise specified in the Detail Specification, all components used for qualification and qualification maintenance, Lot Validation Testing and for delivery, shall be subjected to tests and inspections in accordance with Chart F3. All components shall be serialised prior to the tests and inspections.
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to:

Unless otherwise specified herein or in the Detail Specification, all lots of components used for qualification and qualification maintenance, Lot Validation Testing and for delivery shall be subjected to tests and inspections in accordance with Chart F3 in the sequence shown. All components shall be serialised prior to the tests and inspections.

- The second sentence "Unless otherwise specified in the Detail Specification, the tests shall be performed in the order shown" has been removed.

(15) Para. 6.2.1 Environmental and Mechanical Test Failure
- "e.g." has been replaced by "i.e.".

- "and External Visual Inspection." has been added after "Contact Engagement and Separation Forces".

(16) Para. 6.2.4 Other Failures
- "External Visual Inspection" amended to "Visual failure.".

(17) Para. 6.4 LOT FAILURE
- The paragraph reference was 4.3.1 and is now 4.3.3.

(18) Para. 6.4.2 Lot Failure During Sample Testing - 2nd sentence amended.
- The second sentence has been amended from: "If a lot failure occurs, a 100% testing may be performed but the cumulative percent defective shall not exceed that given in Para. 6.4.1." to "Unless otherwise specified, if a lot failure occurs, a 100% testing may be performed but the cumulative percent defective shall not exceed that specified in Para. 6.4.1.".

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(19) Section 7 QUALIFICATION, QUALIFICATION MAINTENANCE AND LOT VALIDATION TESTING
- Amended from: "Requirements of this paragraph are applicable to the tests performed for component type qualification and qualification maintenance and also for Lot Validation Testing." to:

The requirements of this paragraph are applicable to the tests performed on components or test structures as part of qualification or qualification maintenance in accordance with either ESCC Basic Specification No. 20100 or 25400 as applicable. They are also applicable to Lot Validation Testing as part of the procurement of qualified or unqualified components.
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(20) Para. 7.1
- Re-named (was COMPONENT TYPE QUALIFICATION TESTING, now QUALIFICATION TESTING).

(21) Para. 7.1.1 General
- The 'q', 't' and 'l' of "qualification test lot" have been capitalised.

- The first sentence, "...with the requirements given in Chart F4." has been changed to "...with the requirements specified in Chart F4.".

- "(Screening Tests)" has been deleted from the end of the second sentence.

- The wording of the last sentence has changed from "The conditions governing component type qualification testing are given in ESCC Basic Specification No. 20100." to "The conditions governing qualification testing are specified in ESCC Basic Specification No. 20100.".

(22) Para. 7.1.2 Distribution within the Qualification Test Lot
- The wording has been amended from:

A sample of 10 components shall be subjected to Qualification Tests as specified in Chart F4.

Where a Detail Specification covers a range or series of mechanically and electrically similar components the components selected for qualification testing must adequately represent all the various mechanical and electrical peculiarities of the components within the range.

The components types may be specified by, but in any case shall be agreed with, the ESCC Executive prior to the commencement of qualification testing.
---
to:

Where a Detail Specification covers a range, or series of components that are considered similar, then the Qualification Test Lot shall be comprised of component types so selected that they adequately represent all of the various mechanical, structural and electrical peculiarities of that range or series.

The distribution shall be specified by, or agreed with, the ESCC Executive.

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(23) A new Para. 7.2, QUALIFICATION WITHIN A TECHNOLOGY FLOW, "The qualification of a component produced using a qualified Technology Flow shall be in accordance with ESCC Basic Specification No. 25400." has been added.

(24) Para. 7.2 QUALIFICATION MAINTENANCE (PERIODIC TESTING)
- Re-numbered 7.3 and the wording changed from:

Component type qualification is maintained through periodic testing and the test requirements of Para. 7.1 shall apply. For each subgroup the period between successive subgroup testing shall be as given in Chart F4. The conditions governing qualification maintenance are given in ESCC Basic Specification No. 20100.

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to:

Qualification is maintained through periodic testing and the test requirements of Para. 7.1 shall apply. For each subgroup the sample size and the period between successive subgroup testing shall be as specified in Chart F4. The conditions governing qualification maintenance are specified in ESCC Basic Specification No. 20100.

Qualification of a component, produced using a qualified Technology Flow, is maintained by the maintenance of the Technology Flow Qualification itself in accordance with ESCC Basic Specification No. 25400.

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(25) Para. 7.3 LOT VALIDATION TESTING
- Re-numbered 7.4 and the existing wording:

7.3.1 General
For qualified components, Lot Validation Testing as defined in compliance with Chart F4, Subgroup 2, shall only be performed on the procured lot if required in the Purchase Order.

If unqualified components are procured using this specification then the Orderer shall define in the Purchase Order the required subgroups from Chart F4 to be used for Lot Validation Testing.

7.3.2 Distribution within the Sample for Lot Validation Testing
Where a Detail Specification covers a range, or series, of components that are considered similar, then it is only necessary to perform Lot Validation Testing on representative types if a number of different types are procured together. The sample

for Lot Validation Testing should be comprised of component types so selected that they adequately represent all of the various mechanical, structural and electrical peculiarities of the components procured from the range or series.

The distribution of component types will vary from procurement to procurement and shall be as required in the Purchase Order.

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has been deleted and replaced with the following:

For procurement of qualified components, Lot Validation Testing is not required and shall only be performed if specifically stipulated in the Purchase Order.

For procurement of unqualified components the need for Lot Validation Testing shall be determined by the Orderer (ref. ESCC Basic Specification No. 23100).

When Lot Validation Testing is required, it shall consist of the performance of one or more of the tests or subgroup test sequences of Chart F4. The testing to be performed and the sample size shall be as stipulated in the Purchase Order.

When procurement of more than one component type is involved from a family, range or series, the selection of representative samples shall also be stipulated in the Purchase Order.

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(26) Para. 7.4 FAILURE CRITERIA, Para. 7.4.1 Environmental and Mechanical Test Failures, Para. 7.4.2 Electrical Failures and Para. 7.4.3 Other Failures
- Re-numbered 7.5, 7.5.1, 7.5.2 and 7.5.3 respectively.

(27) Para. 7.5 FAILED COMPONENTS
- Re-numbered 7.6.

- First sentence, paragraph reference changed from Para. 7.4 to Para. 7.5.

- Wording in the second sentence amended from "...performed by the Manufacturer and..." to "... performed under the responsibility of the Manufacturer and...".

(28) Para. 7.6 LOT FAILURE
- Re-numbered 7.7.

- Last part of first sentence re-worded (was "...according to Chart F4 has been exceeded.", now "...specified in Chart F4 has been exceeded.").

- Paragraph reference in last sentence changed from Para. 4.3.1 to Para. 4.3.3.

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(29) Para. 7.7 QUALIFICATION, QUALIFICATION MAINTENANCE AND LOT VALIDATION TESTING SAMPLES and Para. 7.8 DOCUMENTATION
- Re-numbered 7.8 and 7.9 respectively.

(30) Para. 8.7 BURN-IN
- The last part of the last sentence has been amended from "... are at 0 hours and T (+24 -0) hours (where T is the specified duration)." to "... are at 0 hours (initial) and T (+24 -0) hours (where T is the specified duration). Drift shall be related to the initial measurement.".

(31) Para. 8.8 EXTERNAL VISUAL INSPECTION AND DIMENSION CHECK
- The final sentence "If a failure occurs the complete lot shall be checked." has been deleted and a new final sentence "In the event of any failure a 100% Dimension Check shall be performed." added.

(32) Para. 8.9.2 (VIBRATION) Procedure
- IEC Publication No. 60068-2-6 does not contain "Procedure B4" and this has therefore been removed. DCR 364 Change Item f) refers.

(33) Para. 8.11.2 (RAPID CHANGE OF TEMPERATURE) Recovery and Visual Inspection
- the "T" of "Temperature" has been corrected to lower case.

(34) Para. 9.1 (DATA DOCUMENTATION) GENERAL
- The sentences regarding availability, supply and format of the data documentation have been amended from:

Whenever possible, documentation should preferably be supplied in electronic format suitable for reading using a compatible PC. The format supplied shall be legible, durable and indexed. The preferred storage media are 3 1/2 inch diskettes or CD-ROMs and the preferred file formats are ASCII or PDF.
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to:

Whenever possible, documentation should preferably be available in electronic format suitable for reading using a compatible PC. The format supplied shall be legible, durable and indexed. The preferred storage medium is CD-ROM and the preferred file format is PDF.
---

(35) Para. 9.1.3 Additional Documentation

- Re-worded from "...if required in the Purchase Order." to "...if stipulated in the Purchase Order.".

(36) Para. 9.2 COVER SHEET(S)
- Item (c): "Manufacturers" has been corrected to "Manufacturer's".

(37) Para. 9.3 LIST OF EQUIPMENT USED
- "if not in accordance with the data given in the PID" has been deleted from the first sentence.

(38) Para. 9.8 FAILED COMPONENTS LIST AND FAILURE ANALYSIS REPORT
- Item (b) has been re-worded: "The" has been replaced by "Traceability information including".

(39) Para. 9.9 CERTIFICATE OF CONFORMITY
- Amended from "A Certificate of Conformity shall be established as defined in ESCC Basic Specification No. 20100." to "A Certificate of Conformity shall be established in accordance with the requirements of ESCC Basic Specification Nos. 20100 or 25400."

(40) Section 10 DELIVERY
- Item (b), "The components used for Lot Validation Testing (when applicable), but not forming part of the delivery lot.", has been changed to "The components used for Lot Validation Testing (as applicable), but not forming part of the delivery lot, if stipulated in the Purchase Order.".

- Item (c), "The relevant documentation in accordance with the requirements of Section 9." has been changed to "The relevant documentation in accordance with the requirements of Paras. 9.1.2 and 9.1.3.".

- The wording of the last sentence has been changed from:

For qualification or qualification maintenance, the disposition of the test lot and its related documentation shall be as specified in ESCC Basic Specification No. 20100 and the relevant paragraphs of Section 9 of this specification.
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to:

For qualification or qualification maintenance, the disposition of the Qualification Test Lot and its related documentation shall be as specified in ESCC Basic Specification Nos. 20100 or 25400 and the relevant paragraphs of Section 9 of this specification.
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(41) Para. 12.1 CHART F1 - GENERAL FLOW FOR PROCUREMENT

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- The 'ESCC Qualified section' of Chart F1 has been amended: Lot Validation Testing "Note 1" reference has been moved, the paragraph reference has been changed from Para. 7.3.1 to Para. 7.4, the wording "Subgroup 2" has been deleted and the paragraph reference for Periodic Testing has been changed from Para. 7.2 to Para. 7.3.

- The 'Not ESCC Qualified section' of Chart F1 has been amended: the paragraph reference has been changed from Para. 7.3 to Para. 7.4 and a reference to Note 2 has been added.

- Note 1 has been re-worded from "Lot Validation Testing is optional for qualified components and shall only be performed if required in the Purchase Order." to "Lot Validation Testing is not required for qualified components unless specifically stipulated in the Purchase Order.".

- New Note 2 "For unqualified components the need for Lot Validation Testing shall be determined by the Orderer and the required testing shall be as stipulated in the Purchase Order (ref. ESCC Basic Specification No. 23100)." has been added.".

(42) Para. 12.2 CHART F2 - PRODUCTION CONTROL
- Para. 5.2.3's title reference has been amended from "Pre-encapsulation Inspection (Internal and External Visual Inspection)" to "Pre-Encapsulation Inspection".

(43) Para. 12.3 CHART F3 - SCREENING TESTS
- Note 1 has been deleted and subsequently Notes 2, 3, and 4 (plus the references to these Notes in the Chart) have been re-numbered accordingly.

- A new initial step, "Serialisation" per Para. 6.1, has been added to the Chart.

(44) Para. 12.4 CHART F4 - QUALIFICATION AND PERIODIC TESTS
- The layout of the Chart has been amended: each Subgroup is now separate because the "10 Components" box, and the "TOTAL FAILURES ALLOWED" section of the Chart has been deleted. The wording "Subgroup 1", "Subgroup 2" and "Subgroup 3" has been deleted.

- The following two Notes have been added:
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1. For distribution within the subgroups see Para. 7.1.2 for qualification and qualification maintenance and Para. 7.4 for Lot Validation Testing.

2. The number of failures allowed is 1 per subgroup but the cumulative number of failures allowed for qualification and qualification maintenance, for all three subgroups, is also 1.

- A new box "4 Components (1) (2)" has been added at the start of the Environmental / Mechanical Subgroup and references to Notes 1 and 2 have been added to the Endurance Subgroup's and Electrical Subgroup's "3 Components"

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boxes.

Justification:

This specification is proposed to be amended to incorporate various editorial amendments and corrections to bring all ESCC generic specifications (that have been converted to the new ESCC format) in line with each other (i.e. ESCC 9000, 5000, 5010, 9020, 4001, 4008, 4009 and 3403).

The content of this DCR amends the editorial content of ESCC 3403 to make it consistent with published ESCC 5000 Issue 4 (ref. Approved DCR 399) as well as making other general editorial amendments for the purposes of correction, clarification and consistency.

Attachments:

3403_Issue_3_Draft_A.pdf, null

Modifications:

Approval by PSWG 45

Approval signature:

Date signed:

2009-08-18

ATTENUATORS AND LOADS, RF, COAXIAL, FIXED

ESCC Generic Specification No. 3403

Issue 3 - Draft A	August 2009

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DCR No.	CHANGE DESCRIPTION
tbd	Specification upissued to incorporate editorial changes per DCR

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1. INTRODUCTION

1.1 SCOPE

This specification defines the general requirements for the qualification, qualification maintenance, procurement, and delivery of fixed RF coaxial attenuators and loads for space applications. This specification contains the appropriate inspection and test schedules and also specifies the data documentation requirements.

1.2 APPLICABILITY

This specification is primarily applicable to the granting of qualification approval to components qualified in accordance with one of the following ESCC methods:

– Qualification of Standard Components per ESCC Basic Specification No. 20100.
– Technology Flow Qualification per ESCC Basic Specification No. 25400.

It is also primarily applicable to the procurement of components so qualified.

This specification may also be applied to the procurement of unqualified components, recommendations for which are given in ESCC Basic Specification No. 23100.

2. APPLICABLE DOCUMENTS

The following documents form part of, and shall be read in conjunction with, this specification. The relevant issues shall be those in effect on the date of starting qualification or placing the Purchase Order.

2.1 ESCC SPECIFICATIONS

– No. 20100, Requirements for the Qualification of Standard Electronic Components for Space Application.
– No. 20500, External Visual Inspection.
– No. 20600, Preservation, Packaging and Dispatch of ESCC Components.
– No. 21300, Terms, Definitions, Abbreviations, Symbols and Units.
– No. 21700, General Requirements for the Marking of ESCC Components.
– No. 22800, ESCC Non-Conformance Control System.
– No. 23100, Recommendations on the use of the ESCC Specification System for the Evaluation and Procurement of Unqualified Components.
– No. 24600, Minimum Quality System Requirements.
– No. 24800, Resistance to Solvents of Marking, Materials and Finishes.
– No. 25400, Requirements for the Technology Flow Qualification of Electronic Components for Space Application.
– No. 3402, Connectors, RF Coaxial.

For qualification and qualification maintenance or procurement of qualified components, with the exception of ESCC Basic Specifications Nos. 20100, 21700, 22800, 24600 and 25400, where Manufacturers' specifications are equivalent to, or more stringent than, the ESCC Basic Specifications listed above, they may be used in place of the latter, subject to the approval of the ESCC Executive.

Such replacements shall be clearly identified in the applicable Process Identification Document (PID).

For procurement of unqualified components, where Manufacturers' specifications are equivalent to or more stringent than the applicable ESCC Basic Specifications listed above, they may be used in place of the latter subject to the approval of the Orderer.

Such replacements may be listed in an appendix to the appropriate Detail Specification at the request of the Manufacturer or Orderer, subject to the approval of the ESCC Executive.

Unless otherwise stated herein, references within the text of this specification to "the Detail Specification" shall mean the relevant ESCC Detail Specification.

2.2 OTHER (REFERENCE) DOCUMENTS

– IEC Publication No. 60068 Part 2, Basic Environmental Testing Procedures.
– ECSS-Q-ST-70-02, Thermal Vacuum Test for the Screening of Space Materials.

2.3 ORDER OF PRECEDENCE

For the purpose of interpretation and in case of conflict with regard to documentation, the following order of precedence shall apply:

(a) ESCC Detail Specification.
(b) ESCC Generic Specification.
(c) ESCC Basic Specification.
(d) Other documents, if referenced herein.

3. TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS

The terms, definitions, abbreviations, symbols and units specified in ESCC Basic Specification No. 21300 shall apply.

4. REQUIREMENTS

4.1 GENERAL

The requirements for qualification of a component shall be in accordance with ESCC Basic Specification No. 20100.

The requirements for Technology Flow Qualification and listing of qualified component types shall be in accordance with ESCC Basic Specification No. 25400.

The test requirements for procurement of both qualified and unqualified components (see Chart F1) shall comprise:

– Special In-Process Controls.
– Screening Tests.
– Periodic Testing (for qualified components only).
– Lot Validation Testing if stipulated in the Purchase Order.

4.1.1 Specifications

For qualification, qualification maintenance, procurement and delivery of components in conformity with this specification, the applicable specifications listed in Section 2 of this document shall apply in total

unless otherwise specified herein or in the Detail Specification.

4.1.2 Conditions and Methods of Test

The conditions and methods of test shall be in accordance with this specification, the ESCC Basic Specifications referenced herein and the Detail Specification.

4.1.3 Manufacturer's Responsibility for Performance of Tests and Inspections

The Manufacturer shall be responsible for the performance of tests and inspections required by the applicable specifications. These tests and inspections shall be performed at the plant of the Manufacturer of the components unless it is agreed by the ESCC Executive (for qualification, qualification maintenance, or procurement of qualified components) or the Orderer (for procurement of unqualified components), to use an approved external facility.

4.1.4 Inspection Rights

The ESCC Executive (for qualification, qualification maintenance, or procurement of qualified components) or the Orderer (for procurement of unqualified components if stipulated in the Purchase Order) reserves the right to monitor any of the tests and inspections scheduled in the applicable specifications.

4.1.5 Pre-Encapsulation Inspection Witnessing

If required in the Purchase Order, the Orderer may witness or perform the Pre-Encapsulation Inspection and the Manufacturer must notify the Orderer at least 2 working weeks before the commencement of the inspection.

4.2 QUALIFICATION AND QUALIFICATION MAINTENANCE REQUIREMENTS ON A MANUFACTURER

To obtain and maintain the qualification of a component, or family of components, a Manufacturer shall satisfy the requirements of ESCC Basic Specification No. 20100.

To obtain and maintain the qualification of a component produced using a qualified Technology Flow, a Manufacturer shall satisfy the requirements of ESCC Basic Specification No. 25400.

4.3 DELIVERABLE COMPONENTS

4.3.1 ESCC Qualified Components

Components delivered to this specification shall be processed and inspected in accordance with the relevant Process Identification Document (PID).

4.3.2 ESCC Components

Each component, irrespective of qualification status, identified with an ESCC component number and delivered to this specification shall:

– be traceable to its production lot.

– have satisfactorily completed all the tests required by the relevant issues of the applicable specifications.
– be produced from lots that are considered by the Manufacturer to be capable of passing all applicable tests, and sequences of tests, that are defined in Chart F4. The Manufacturer shall not knowingly supply components that cannot meet this requirement. In the event that, subsequent to delivery and prior to operational use, a component is found to be in a condition such that, demonstrably, it could not have passed these tests at the time of manufacture, this shall be grounds for rejection of the delivered lot.

4.3.3 Lot Failure

Lot failure may occur during Special In-Process Controls (Chart F2), Screening Tests (Chart F3) or Qualification and Periodic Tests (Chart F4).

Should such failure occur during qualification, qualification maintenance or procurement of qualified components the Manufacturer shall initiate the non-conformance procedure in accordance with ESCC Basic Specification No. 22800. The Manufacturer shall notify the Orderer and the ESCC Executive by any appropriate written means, within 5 working days, giving details of the number and mode of failure and the suspected cause. No further testing or analysis shall be performed on the failed components until so instructed by the ESCC Executive.

Should such failure occur during procurement of unqualified components the Manufacturer shall notify the Orderer by any appropriate written means within 5 working days, giving details of the number and mode of failure and the suspected cause. No further testing or analysis shall be performed on the failed components until so instructed by the orderer. The Orderer shall inform the Manufacturer within 5 working days of receipt of notification what action shall be taken.

4.4 MARKING

All components procured and delivered to this specification shall be marked in accordance with ESCC Basic Specification No. 21700.

4.5 MATERIALS AND FINISHES

Specific requirements for materials and finishes are specified in the Detail Specification. Where a definite material or finish is not specified a material or finish shall be used so as to ensure that the component meets the performance requirements of this specification and the Detail Specification. Acceptance or approval of any constituent material or finish does not guarantee acceptance of the finished product.

All non-metallic materials and finishes of the components specified in the Detail Specification shall meet the outgassing requirements as outlined in ECSS-Q-ST-70-02.

5. PRODUCTION CONTROL

5.1 GENERAL

Unless otherwise specified herein or in the Detail Specification, all lots of components used for qualification and qualification maintenance, Lot Validation Testing and for delivery shall be subject to tests and inspections in accordance with Chart F2 in the sequence shown.

Any components which do not meet these requirements shall be removed from the lot and at no future time be resubmitted to the requirements of this specification.

The applicable test requirements are detailed in the paragraphs referenced in Chart F2.

For qualified components the full production control provisions are defined in the PID.

5.2 SPECIAL IN-PROCESS CONTROLS

5.2.1 Contact Engagement and Separation Forces

A sample of 13 female centre contacts shall be tested for Contact Engagement and Separation Forces as defined in Para. 8.1. If any failure occurs the lot of contacts shall be rejected.

5.2.2 Gold Plate Porosity

A sample of 10 contacts from each plating lot shall be tested for Gold Plate Porosity as defined in Para. 8.2. If any failure occurs the plating lot shall be rejected.

5.2.3 Pre-Encapsulation Inspection

Pre-Encapsulation Inspection shall consist of internal and external visual inspection of all the different elements of the components in accordance with Para. 8.3.

5.2.4 Dimension Check

Dimension Check shall be performed in accordance with Para. 8.8 on 3 samples only.

In the event of any failure a 100% Dimension Check shall be performed.

5.2.5 Weight

The maximum weight of the component specified in the Detail Specification shall be guaranteed but not tested.

5.2.6 Documentation

Documentation of Special In-Process Controls shall be in accordance with Para. 9.5.

6. SCREENING TESTS

6.1 GENERAL

Unless otherwise specified herein or in the detail specification, all lots of components used for qualification and qualification maintenance, Lot Validation Testing, and for delivery, shall be subjected to tests and inspections in accordance with Chart F3 in the sequence shown. All components shall be serialised prior to the tests and inspections.

Any components which do not meet these requirements shall be removed from the lot and at no future time be resubmitted to the requirements of this specification.

The applicable test methods and conditions are specified in the paragraphs referenced in Chart F3.

6.2 FAILURE CRITERIA

6.2.1 Environmental and Mechanical Test Failure

The following shall be counted as component failures:- components which fail during tests for which the pass/fail criteria are inherent in the test method, i.e. Vibration Cycling, Contact Engagement and

Separation Forces and External Visual Inspection.

6.2.2 Parameter Drift Failure

The acceptable change limits are shown in Parameter Drift Values in the Detail Specification. A component shall be counted as a parameter drift failure if the changes during Burn-in are larger than the drift values (Δ) specified.

6.2.3 Parameter Limit Failure

A component shall be counted as a limit failure if one or more parameters exceed the limits shown in Room Temperature Electrical Measurements or High and Low Temperatures Electrical Measurements in the Detail Specification.

Any component which exhibits a limit failure prior to the submission to Burn-in shall be rejected and not counted when determining lot rejection.

6.2.4 Other Failures

A component shall be counted as a failure in any of the following cases:

– Visual failure.
– Mechanical failure.
– Handling failure.
– Lost component.

Any failure prior to the submission to Burn-in shall be rejected and not counted when determining lot rejection.

6.3 FAILED COMPONENTS

A component shall be considered as a failed component if it exhibits one or more of the failure modes described in Para. 6.2.

6.4 LOT FAILURE

In the case of lot failure, the Manufacturer shall act in accordance with Para. 4.3.3.

6.4.1 Lot Failure during 100% Testing

If the number of components failed on the basis of the failure criteria described in Para. 6.2 equals or exceeds:

– 6% (rounded upwards to the nearest whole number) of a lot larger than 50 components
– 3 devices of a lot of between 20 and 50 components
– 2 devices of a lot smaller than 20 components

the lot shall be considered as failed.

If a lot is composed of groups of components of one family defined in one ESCC Detail Specification, but separately identifiable for any reason, then the lot failure criteria shall apply separately to each identifiable group.

6.4.2 Lot Failure during Sample Testing

A lot shall be considered as failed if the number of allowable failures during sample testing as specified in the Detail Specification, is exceeded.

Unless otherwise specified, if a lot failure occurs, a 100% testing may be performed but the cumulative percent defective shall not exceed that specified in Para. 6.4.1.

6.5 DOCUMENTATION

Documentation of Screening Tests shall be in accordance with Para. 9.6.

7. QUALIFICATION, QUALIFICATION MAINTENANCE AND LOT VALIDATION TESTING

The requirements of this paragraph are applicable to the tests performed on components or test structures as part of qualification or qualification maintenance in accordance with either ESCC Basic Specification No. 20100 or 25400 as applicable. They are also applicable to Lot Validation Testing as part of the procurement of qualified or unqualified components.

7.1 QUALIFICATION TESTING

7.1.1 General

Qualification testing shall be in accordance with the requirements specified in Chart F4. The tests of Chart F4 shall be performed on the specified sample chosen at random from components which have successfully passed the tests in Chart F3. This sample constitutes the Qualification Test Lot.

The Qualification Test Lot is divided into subgroups of tests and all components assigned to a subgroup shall be subjected to all of the tests in that subgroup, in the sequence shown. The applicable test requirements are detailed in the paragraphs referenced in Chart F4.

The conditions governing qualification testing are specified in ESCC Basic Specification No. 20100.

7.1.2 Distribution within the Qualification Test Lot

Where a Detail Specification covers a range, or series of components that are considered similar, then the Qualification Test Lot shall be comprised of component types so selected that they adequately represent all of the various mechanical, structural and electrical peculiarities of that range of series.

The distribution shall be as specified by, or agreed with, the ESCC Executive.

7.2 QUALIFICATION WITHIN A TECHNOLOGY FLOW

The qualification of a component produced using a qualified Technology Flow shall be in accordance with ESCC Basic Specification No. 25400.

7.3 QUALIFICATION MAINTENANCE (PERIODIC TESTING)

Qualification is maintained through periodic testing and the test requirements of Para. 7.1 shall apply. For each subgroup the sample size and the period between successive subgroup testing shall be as specified in Chart F4. The conditions governing qualification maintenance are specified in ESCC Basic Specification No. 20100.

Qualification of a component, produced using a qualified Technology Flow, is maintained by

maintenance of the Technology Flow Qualification itself in accordance with ESCC Basic Specification No. 25400.

7.4 LOT VALIDATION TESTING

For procurement of qualified components, Lot Validation Testing is not required and shall only be performed if specifically stipulated in the Purchase Order.

For procurement of unqualified components the need for Lot Validation Testing shall be determined by the Orderer (ref. ESCC Basic Specification No. 23100).

When Lot Validation Testing is required, it shall consist of the performance of one or more of the tests or subgroup test sequences of Chart F4. The testing to be performed and the sample size shall be as stipulated in the Purchase Order.

When procurement of more than one component type is involved from a family, range or series, the selection of representative samples shall also be stipulated in the Purchase Order.

7.5 FAILURE CRITERIA

The following criteria shall apply to qualification, qualification maintenance and Lot Validation Testing.

7.5.1 Environmental and Mechanical Test Failures

The following shall be counted as component failures:

Components which fail during tests for which the pass/fail criteria are inherent in the test method, e.g. Coupling Proof Torque.

7.5.2 Electrical Failures

The following shall be counted as component failures:

Components which fail one or more of the applicable limits at each of the relevant data points specified for environmental, mechanical and endurance testing in Intermediate and End-Point Electrical Measurements in the Detail Specification.

7.5.3 Other Failures

A component shall be counted as a failure in any of the following cases:

– Visual failure.
– Mechanical failure.
– Handling failure.
– Lost component.

7.6 FAILED COMPONENTS

A component shall be considered as failed if it exhibits one or more of the failure modes detailed in Para. 7.5.

When requested by the ESCC Executive (for qualification, qualification maintenance or procurement of qualified components) or the Orderer (for procurement of qualified or unqualified components), failure

analysis of failed components shall be performed under the responsibility of the Manufacturer and the results provided.

Failed components from successful lots shall be marked as such and be stored at the Manufacturer's plant for a minimum of 24 months.

Failed components shall be retained at the Manufacturer's plant until the final disposition has been agreed and certified.

7.7 LOT FAILURE

For qualification and qualification maintenance, the lot shall be considered as failed if the allowable number of failures specified in Chart F4 has been exceeded.

For procurement, the lot shall be considered as failed if the allowable number of failures according to the applicable tests specified for Lot Validation Testing in Chart F4 has been exceeded.

In the case of lot failure, the Manufacturer shall act in accordance with Para. 4.3.3.

7.8 QUALIFICATION, QUALIFICATION MAINTENANCE AND LOT VALIDATION TESTING SAMPLES

All tests of Chart F4 are considered to be destructive and therefore components so tested shall not form part of the delivery lot.

7.9 DOCUMENTATION

Documentation of qualification, qualification maintenance and Lot Validation Testing shall be in accordance with Para. 9.7.

8. TEST METHODS AND PROCEDURES

If a Manufacturer elects to eliminate or modify a test method or procedure, the Manufacturer is still responsible for delivering components that meet all of the performance, quality and reliability requirements defined in this specification and the Detail Specification.

For a qualified component, documentation supporting the change shall be approved by the ESCC Executive and retained by the Manufacturer. It shall be copied, when requested, to the ESCC Executive. The change shall be specified in an appendix to the Detail Specification and in the PID.

For an unqualified component the change shall be approved by the Orderer. The change may be specified in an appendix to the Detail Specification at the request of the Manufacturer or Orderer, subject to the approval of the ESCC Executive.

8.1 CONTACT ENGAGEMENT AND SEPARATION FORCES

The female contacts shall be tested as follows:

A force which is gradually increased shall be applied with force speed not exceeding 1mm/second until the steel test pin properly engages with, or separates from, the female connectors. The polished steel test pins shall be as specified in the Detail Specification. The oversize test pin shall be engaged and separated from each female contact 3 times. Then the engagement force shall be measured with the maximum diameter test pin. Subsequently, the minimum diameter test pin shall be engaged and separated once to measure the withdrawal force. The engagement and separation forces shall meet the

limits specified in the Detail Specification.

8.2 GOLD PLATE POROSITY

The contacts shall be placed in a clean glass container. A solution of 1 part of concentrated nitric acid (specific gravity: 1.42) and 1 part distilled water at a temperature of +25 ±5˚C shall be poured over the contacts. No bubbles shall emanate from the contact surfaces within 15 seconds from application of the solution.

8.3 PRE-ENCAPSULATION INSPECTION

Prior to assembly, the different elements of components shall be inspected in accordance with the requirements of ESCC Basic Specification No. 20500.

8.4 THERMAL CYCLING

The components shall be subjected to Test Na of IEC Publication No. 60068-2-14. The number of cycles shall be 5 with 30 minutes at each temperature extreme, except that the lower and upper temperatures shall be -30 and +100˚C respectively.

8.5 VIBRATION CYCLING

The components shall be subjected to Vibration in accordance with Para. 8.9 except for the following:

– The number of cycles shall be 3 (1 in each of the 3 directions).
– The electrical continuity during testing shall not be monitored.
– The final electrical measurements shall not be performed.

8.6 ELECTRICAL MEASUREMENTS

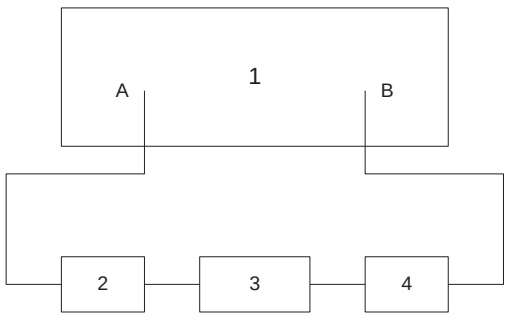
8.6.1 General

Unless otherwise specified in the Detail Specification, the following measurements shall be made in still air, free space and at the standard atmospheric conditions.

8.6.1.1 Voltage Standing Wave Ratio (VSWR) (Attenuators and Loads)

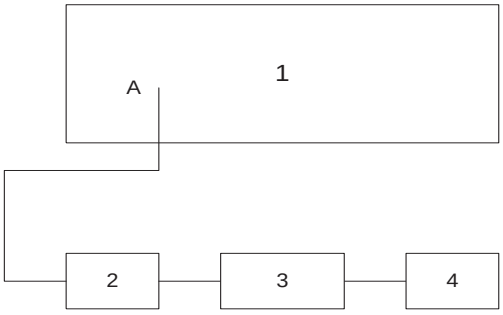
The VSWR shall be measured in accordance with the test set-up shown below.

VSWR TEST SET-UP (2 PORTS)
(ATTENUATORS ONLY)



1. Vector network analyser with RF generator and S parameter test set.
2. Cable assembly.
3. Device under test.
4. Cable assembly.

VSWR TEST SET-UP (1 PORT)
(ATTENUATORS OR LOADS)



1. Vector network analyser with RF generator and S parameter test set.
2. Cable assembly.
3. Device under test.
4. Precision termination (reflection coefficient better than 0.017 (-35dB) in the test frequency range.

NOTE: 4 is only required for the testing of Attenuators.

Unless otherwise specified, VSWR shall be measured either across the full frequency range as specified in the Detail Specification by a swept frequency technique or at equally spaced fixed frequencies (7 minimum) across the frequency range. VSWR shall be measured at both ends for Attenuators. The measured values shall not exceed the limits given in the Detail Specification.

8.6.1.2 Attenuation (Attenuators Only)

Attenuation shall be measured in accordance with the same 2 port test set-up as used for VSWR or equivalent. Unless otherwise specified, Attenuation shall be measured either across the full frequency range as specified in the Detail Specification by a swept frequency technique or at equally spaced fixed frequencies (7 minimum) across the frequency range. The measured values shall not exceed the limits given in the Detail Specification.

8.6.1.3 Resistance (Loads Only)

This measurement shall be made as specified in the Detail Specification.

8.6.2 Parameter Drift Values

At each of the relevant data points during Screening Tests, Parameter Drift Values shall be measured as specified in the Detail Specification. All values obtained shall be recorded against serial numbers and the parameter drift calculated.

8.6.3 High and Low Temperatures Electrical Measurements

High and Low Temperatures Electrical Measurements shall be performed as specified in the Detail

Specification. All values obtained shall be recorded against serial numbers. Unless otherwise specified measurements shall be performed on a sample of 2 components with 0 failures allowed. Alternatively a 100% inspection may be performed.

8.6.4 Room Temperature Electrical Measurements

Room Temperature Electrical Measurements shall be performed as specified in the Detail Specification. All values obtained shall be recorded against serial numbers.

8.6.5 Intermediate and End-Point Electrical Measurements

At each of the relevant data points during Qualification and Periodic Tests, Intermediate and End-point Electrical Measurements shall be performed as specified in the Detail Specification. All values obtained shall be recorded against serial numbers and the parameter drift calculated, if specified.

8.7 BURN-IN

Unless otherwise specified the components shall be subjected to a high temperature storage with zero power applied for a period of 168 (+24 -0) hours as specified in Burn-in in the Detail Specification.

After removal from the test chamber the components shall be visually examined and there shall be no evidence of damage.

The data points for electrical measurements, as specified in Parameter Drift Values in the Detail Specification, are at 0 hours (initial) and T (+24 -0) hours (where T is the specified duration). Drift shall be related to the initial measurement.

8.8 EXTERNAL VISUAL INSPECTION AND DIMENSION CHECK

External Visual Inspection shall be performed in accordance with ESCC Basic Specification No. 20500.

Dimension Check (during Special In-Process Controls only) shall be performed in accordance with ESCC Basic Specification No. 20500 and the Detail Specification on a sample of 3 components. In the event of any failure a 100% Dimension Check shall be performed.

8.9 VIBRATION

8.9.1 Mounting

The components shall be mechanically connected to the vibration generator either directly or by means of a fixture. Mounting fixtures shall enable the components to be vibrated in 3 mutually perpendicular axes in turn, which should be so chosen that faults are most likely to be revealed. If the component is provided with specific means of mounting, they shall be used as specified in the Detail Specification and any additional restraining straps should be avoided. Unless otherwise specified, components not provided with specific means of mounting shall be clamped by the body. If external connections, necessary for measuring and supply purposes, are specified in the Detail Specification, they should add the minimum restraint and mass.

8.9.2 Procedure

The components shall be subjected to Test Fc of IEC Publication No. 60068-2-6, sweep frequency: 10-2000-10 Hz. The entire frequency range of 10 to 2000Hz and return to 10Hz shall be traversed in 10 minutes. This cycle shall be performed 12 times in each of the 3 directions (i.e. 36 times in total), so that the motion is applied for a total period of approximately 6 hours. The vibration amplitude shall be 1.5mm

(20g)(total displacement).

After Vibration, the components shall be visually inspected and there shall be no evidence of damage.

8.9.3 Electrical Measurements

After Vibration electrical measurements as specified in Intermediate and End-Point Electrical Measurements in the Detail Specification shall be performed and shall not exceed the specified limits. If parameter drift is specified initial measurements also shall be performed.

During the last cycle in each direction, an electrical measurement shall be made to determine intermittent contact of 0.5ms or longer duration, or open or short circuiting.

8.10 SHOCK

8.10.1 Mounting

The components shall be mechanically connected to the shock machine either directly or by means of a fixture. Mounting fixtures shall enable the components to be subjected to shocks in 3 mutually perpendicular axes in turn, which should be so chosen that faults are most likely to be revealed. If the component is provided with specific means of mounting, they shall be used as specified in the Detail Specification and any additional restraining straps should be avoided. Unless otherwise specified, components not provided with specific means of mounting shall be clamped by the body. If external connections, necessary for measuring and supply purposes, are specified in the Detail Specification, they should add the minimum restraint and mass.

8.10.2 Procedure

The components shall be subjected to Test Ea of IEC Publication No. 60068-2-27. Unless otherwise specified in the Detail Specification, the following conditions shall apply:

– Shape of shock pulse: Half-sine
– Peak acceleration: 100g.
– Duration of pulse: 6ms.
– Number of shocks: 18 (3 shocks in each direction along the 3 perpendicular axes of the test specimen).

After Shock, the components shall be visually inspected and there shall be no evidence of damage.

8.10.3 Electrical Measurements

After Shock electrical measurements as specified in Intermediate and End-Point Electrical Measurements in the Detail Specification shall be performed and shall not exceed the specified limits. If parameter drift is specified initial measurements also shall be performed.

8.11 RAPID CHANGE OF TEMPERATURE

8.11.1 Procedure

The components shall be subjected to Test Na of IEC Publication No. 60068-2-14. The number of cycles shall be 10 with 30 minutes at each storage temperature extreme as specified in the Detail Specification.

8.11.2 Recovery and Visual Inspection

The duration of recovery shall be 24 ± 2 hours at room temperature conditions. After recovery, the components shall be visually examined and there shall be no evidence of damage.

8.11.3 Electrical Measurements

After recovery electrical measurements as specified in Intermediate and End-Point Electrical Measurements in the Detail Specification shall be performed and shall not exceed the specified limits. If parameter drift is specified initial measurements also shall be performed.

8.12 CLIMATIC SEQUENCE

8.12.1 Dry Heat

The components shall be subjected to Test Ba of IEC Publication No. 60068-2-2. Duration: 2 hours. Maximum operating temperature as specified in the Detail Specification. While still at the specified high temperature and at the end of the period of high temperature, electrical measurements as specified in Intermediate and End-Point Electrical Measurements in the Detail Specification shall be performed and shall not exceed the specified limits.

8.12.2 Damp Heat, Accelerated, First Cycle

Unless otherwise specified in the Detail Specification, the components shall be subjected to Test D of IEC Publication No. 60068-2-30 for one cycle of 24 hours. After recovery, the components shall be subjected immediately to the Cold test.

8.12.3 Cold

The components shall be subjected to Test Aa of IEC Publication No. 60068-2-1. Duration: 2 hours. Minimum operating temperature as specified in the Detail Specification. While still at the specified low temperature and at the end of the period of low temperature, electrical measurements as specified in Intermediate and End-Point Electrical Measurements in the Detail Specification shall be performed and shall not exceed the specified limits.

8.12.4 Low Air Pressure

The components shall be subjected to Test M of IEC Publication No. 60068-2-13 under the following conditions.

– 1 or 2 minutes at 85mbar.
– Temperature: +15 to +25˚C.

Rated DC power as specified in the Detail Specification shall be applied to one end of the Attenuator under test while the other end shall be connected to a matched fixed coaxial load, for 1 to 2 minutes immediately after the pressure of 85mbar has been attained.

When Loads are tested alone, rated DC power shall be applied directly.

8.12.5 Damp Heat, Accelerated, Remaining Cycles

The components shall be subjected to Test D of IEC Publication No. 60068-2-4 for 5 cycles of 24 hours.

8.12.6 Recovery and Visual Inspection

After a recovery period of 1 to 24 hours, the components shall be visually inspected and there shall be no evidence of mechanical damage.

8.12.7 Electrical Measurements

After recovery electrical measurements as specified in Intermediate and End-Point Electrical Measurements in the Detail Specification shall be performed and shall not exceed the specified limits. If parameter drift is specified initial measurements also shall be performed.

8.13 COUPLING PROOF TORQUE

The component shall be engaged with its mating counterpart (gauge) and the coupling nut tightened to the torque as specified in the Detail Specification. After 1 minute, the connected pair shall be disconnected. The coupling mechanism shall not be dislodged and the interface dimensions of the component shall remain as specified in the Detail Specification.

8.14 MATING AND UNMATING FORCES

8.14.1 Bayonet and Screw Coupling

The component shall be mated with its mating gauge. During the entire mating or unmating cycle (until the component is fully mated or unmated), the necessary torque shall not exceed the value specified in the Detail Specification.

A screw-coupling component is fully mated with its mating gauge when their reference planes coincide.

A bayonet-coupling component is fully mated with its mating gauge when the bayonet studs have passed the detent and their reference planes coincide.

No additional tightening torque shall be applied.

The gauge is a steel jig containing the interface dimensions specified in the Detail Specification.

8.14.2 Push-Pull Coupling

The component under test shall be mated with its mating gauge. During this engaging cycle, the force necessary to fully mate the connectors shall not exceed the value specified in the Detail Specification.

Upon completion of mating, an opposite force necessary for unmating shall be applied. This force shall be within the limits specified.

8.15 CONNECTOR REPEATABILITY (ATTENUATORS ONLY)

The components shall be tested for Connector Repeatability. The following details shall apply:

- Perform 10 complete engagements and separations, both ends separately.
- Electrical measurements as specified in Intermediate and End-Point Electrical Measurements in the Detail Specification shall be performed before and after each engagement and separation. As a minimum Attenuation at 3 frequencies shall be performed (1 from each 1/3 of the rated frequency range).
- Rotate Attenuator through the full 360^{o} with an increment of approximately 36^{o} for each engagement.
- Cleaning of connectors or reshaping of contacts is not permitted during the test sequence.
- Side-thrust shall not be permitted during the test.

8.16 OPERATING LIFE

8.16.1 Initial Measurements

Electrical measurements as specified in Intermediate and End-Point Electrical Measurements in the Detail Specification shall be performed and shall not exceed the specified limits.

8.16.2 Mounting

The components shall be placed on a rack of insulating material or suspended in the oven. There shall be no undue draught over the components, only natural convection resulting from the hot components may occur.

8.16.3 Testing

The components shall be subjected to an Operating Life test of 1000 (+48 -0) hours at the ambient temperature as specified in Operating Life in the Detail Specification.

They shall be tested at rated RF input power as specified in the Detail Specification applied in cycles of 1.5 hours 'on' and 0.5 hours 'off' throughout the test. The 0.5 hours 'off' periods are included in the total test duration. Unless otherwise specified the test frequency shall be 10GHz.

After not less than 1000 hours, the components shall be removed from the chamber and allowed to cool under standard atmospheric conditions prior to final measurements for not less than 1 hour and not more than 2 hours.

The removal from the chamber shall take place at the end of the half-hour 'off' period.

8.16.4 Final Measurements

Electrical measurements as specified in Intermediate and End-Point Electrical Measurements in the Detail Specification shall be performed and shall not exceed the specified limits.

8.17 PERMANENCE OF MARKING

ESCC Basic Specification No. 24800.

8.18 RESIDUAL MAGNETISM (GOLD-PLATED WITH COPPER UNDERPLATE VERSION ONLY)

After submission to a magnetic field of 200 gauss, the components shall exhibit a residual magnetism of less than 20γ (1γ = 10^{-5} gauss), measured at 3mm from the component.

8.19 RF LEAKAGE

The RF Leakage shall be measured across the full frequency range as specified in the Detail Specification either by a swept frequency technique or at fixed frequencies in steps not exceeding an octave band. As a minimum, 3 frequencies shall be selected (1 from each 1/3 of the rated frequency range).

RF Leakage shall be measured by means of an RF antenna positioned at a distance of 1cm from all points around the component under test.

Rated RF power as specified in the Detail Specification shall be applied to the component during the test in still air and free space at the standard atmospheric conditions.

RF Leakage as specified in the Intermediate and End-Point Electrical Measurements in the Detail Specification shall not exceed the specified limits.

8.20 PEAK POWER

The component shall be placed in still air and free space at the standard atmospheric conditions. Rated peak power (DC condition unless otherwise specified) as specified in the Detail Specification shall be applied 10 times to each end of the Attenuators or to the Load for the specified time. The other end of the Attenuator shall be connected to a matched fixed coaxial load. After the component has cooled down

to standard inspection conditions, electrical measurements as specified in the Intermediate and End-Point Electrical Measurements in the Detail Specification shall be performed and shall not exceed the specified limits.

8.21 POWER SENSITIVITY (ATTENUATORS ONLY)

The change in attenuation shall be determined from measurements at rated RF power and the reference power level as specified in the Intermediate and End-Point Electrical Measurements in the Detail Specification.

8.22 CORROSION

The components mated with protective connectors shall be submitted to this test in accordance with IEC Publication No. 60068-2-11 for a duration of 48 hours. After exposure, they shall be washed, shaken and lightly brushed and then allowed to dry at +40^{o}C for 24 hours. The components shall then be inspected. No base metal shall be exposed.

9. DATA DOCUMENTATION

9.1 GENERAL

For the qualification, qualification maintenance and procurement for each lot a data documentation package shall exist in a printed or electronic form.

This package shall be compiled from:

(a) Cover sheet (or sheets).
(b) List of equipment (testing and measuring).
(c) List of test references.
(d) Special In-Process Controls data (Chart F2).
(e) Screening Tests data (Chart F3).
(f) Qualification and Periodic Tests data including Lot Validation Testing Data (when applicable) (Chart F4).
(g) Failed components list and failure analysis report (when applicable).
(h) Certificate of Conformity.

Items (a) to (h) inclusive shall be grouped, preferably as subpackages and, for identification purposes, each page shall include the following information:

– ESCC Component Number.
– Manufacturer's name.
– Lot identification.
– Date of establishment of the document.
– Page number.

Whenever possible, documentation should preferably be available in electronic format suitable for reading using a compatible PC. The format supplied shall be legible, durable and indexed. The preferred storage medium is CD-ROM and the preferred file format is PDF.

9.1.1 Qualification and Qualification Maintenance

In the case of qualification or qualification maintenance, the items listed in Para. 9.1(a) to (h) are required.

9.1.2 Component Procurement and Delivery

For all deliveries of components procured to this specification, the following documentation shall be supplied:

(a) Cover sheet (if all of the information is not included on the Certificate of Conformity).
(b) Certificate of Conformity (including range of delivered serial numbers).

9.1.3 Additional Documentation

The Manufacturer shall deliver additional documentation containing data and reports to the Orderer, if stipulated in the Purchase Order.

9.1.4 Data Retention/Data Access

If not delivered, all data shall be retained by the Manufacturer for a minimum of 5 years during which time it shall be available for review, if requested, by the Orderer or the ESCC Executive (for qualified components).

9.2 COVER SHEET(S)

The cover sheet(s) of the data documentation package shall include as a minimum:

(a) Reference to the Detail Specification, including issue and date.
(b) Reference to the applicable ESCC Generic Specification, including issue and date.
(c) ESCC Component Number and the Manufacturer's part type number.
(d) Lot identification.
(e) Range of delivered serial numbers.
(f) Number of the Purchase Order.
(g) Information relative to any additions to this specification and/or the Detail Specification.
(h) Manufacturer's name and address.
(i) Location of the manufacturing plant.
(j) Signature on behalf of Manufacturer.
(k) Total number of pages of the data package.

9.3 LIST OF EQUIPMENT USED

A list of equipment used for tests and measurements shall be prepared. Where applicable, this list shall contain inventory number, Manufacturer's type number, serial number, etc. This list shall indicate for which tests such equipment was used.

9.4 LIST OF TEST REFERENCES

This list shall include all Manufacturer's references or codes which are necessary to correlate the test data provided with the applicable tests specified in the tables of the Detail Specification.

9.5 SPECIAL IN-PROCESS CONTROLS DATA (CHART F2)

A test result summary shall be compiled showing the total number of components submitted to, and the total number rejected after each of the tests. For Contact Engagement and Separation Forces the measurements shall be recorded.

9.6 SCREENING TESTS DATA (CHART F3)

A test result summary shall be compiled showing the total number of components submitted to, and the total number rejected after each of the tests. For each test requiring electrical measurements the results shall be recorded against component serial number. Component drift calculations shall be recorded for each specified test against component serial number.

9.7 QUALIFICATION AND PERIODIC TESTS DATA (CHART F4)

9.7.1 Qualification Testing

A test result summary shall be compiled showing the components submitted to and the number rejected after each test in each subgroup. Component serial numbers for each subgroup shall be identified. For each test requiring electrical measurements the results shall be recorded against component serial number. Where a drift value is specified during a test the drift calculation shall be recorded against component serial number.

9.7.2 Periodic Testing for Qualification Maintenance

A test result summary shall be compiled showing the components submitted to and the number rejected after each test in each subgroup. Component serial numbers for each subgroup shall be identified. For each test requiring electrical measurements the results shall be recorded against component serial number. Where a drift value is specified during a test the drift calculation shall be recorded against component serial number.

In addition to the full test data a report shall be compiled for each subgroup of Chart F4 to act as the most recent Periodic Testing summary. These reports shall include a list of all tests performed in each subgroup, the ESCC Component Numbers and quantities of components tested, a statement confirming all the results were satisfactory, the date the tests were performed and a reference to the full test data.

9.7.3 Lot Validation Testing

A test result summary shall be compiled showing the components submitted to and the number rejected after each test in each subgroup (as applicable). Component serial numbers for each subgroup shall be identified. For each test requiring electrical measurements the results shall be recorded against component serial number. Where a drift value is specified during a test the drift calculation shall be recorded against component serial number.

9.8 FAILED COMPONENTS LIST AND FAILURE ANALYSIS REPORT

The failed components list and failure analysis report shall provide full details of:

(a) The reference and description of the test or measurement performed as defined in this specification and/or the Detail Specification during Special In-Process Controls, Screening Tests and Qualification and Periodic Tests.
(b) Traceability information including serial number (if applicable) of the failed component.
(c) The failed parameter and the failure mode of the component.
(d) Detailed failure analysis (if requested by the ESCC Executive or Orderer).

9.9 CERTIFICATE OF CONFORMITY

A Certificate of Conformity shall be established in accordance with the requirements of ESCC Basic Specification Nos. 20100 or 25400.

10. DELIVERY

For procurement, for each order, the items forming the delivery are:

(a) The delivery lot.
(b) The components used for Lot Validation Testing (as applicable), but not forming part of the delivery lots, if stipulated in the Purchase Order.
(c) The relevant documentation in accordance with the requirements of Paras. 9.1.2 and 9.1.3.

In the case of a component for which a valid qualification is in force, all data of all components submitted to Lot Validation Testing shall also be copied, when requested, to the ESCC Executive.

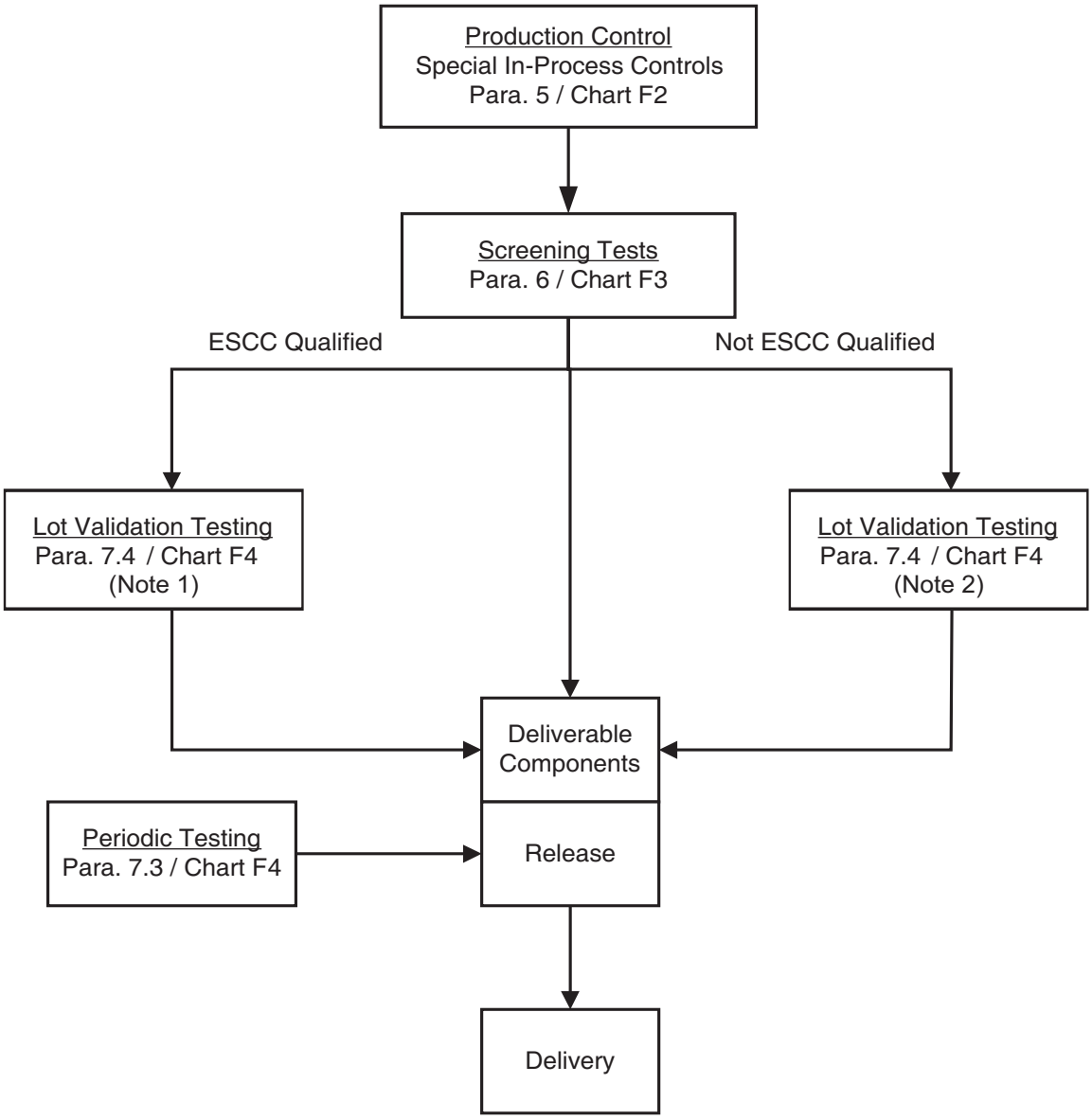
For qualification or qualification maintenance, the disposition of the Qualification Test Lot and its related documentation shall be as specified in ESCC Basic Specification No. 20100 or 25400 and the relevant paragraphs of Section 9 of this specification.

11. PACKAGING AND DISPATCH

The packaging and dispatch of components to this specification shall be in accordance with the requirements of ESCC Basic Specification No. 20600.

12. CHARTS

12.1 CHART F1 - GENERAL FLOW FOR PROCUREMENT



NOTES:

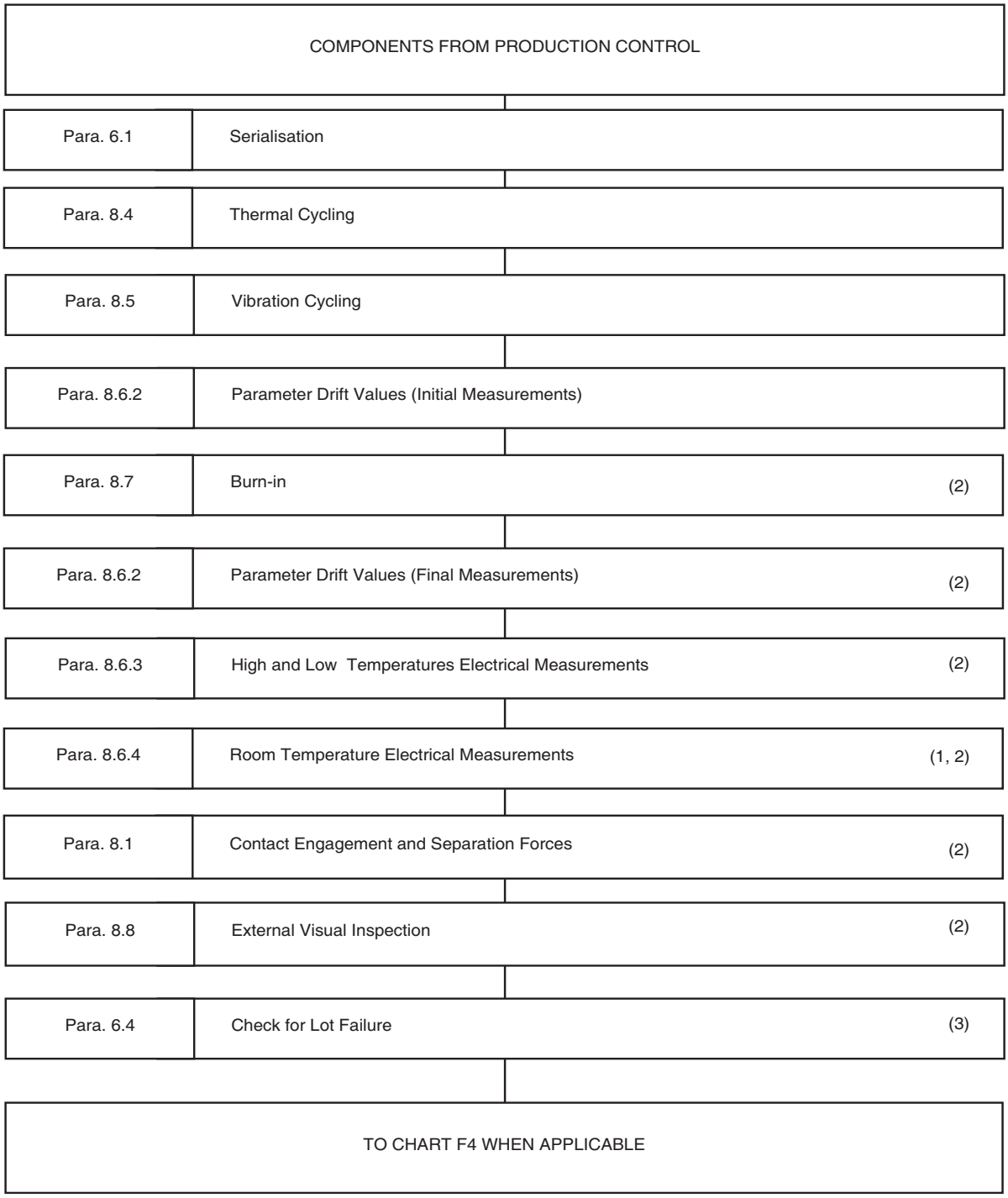
1. Lot Validation Testing is not required for qualified components unless specifically stipulated in the Purchase Order.
2. For unqualified components the need for Lot Validation Testing shall be determined by the Orderer and the required testing shall be as stipulated in the Purchase Order (ref. ESCC Basic Specification No. 23100).

12.2 CHART F2 - PRODUCTION CONTROL

COMPONENT LOT MANUFACTURING		
SPECIAL IN-PROCESS CONTROLS		
Para. 5.2.1	Contact Engagement and Separation Forces	(1)
Para. 5.2.2	Gold Plate Porosity	(1)
Para. 5.2.3	Pre-Encapsulation Inspection	
-	Assembly	
Para. 5.2.4	Dimension Check	(1)
Para. 5.2.5	Weight	(2)
TO CHART F3 - SCREENING TESTS		

NOTES:
1. Performed on a sample basis.
2. Guaranteed but not tested.

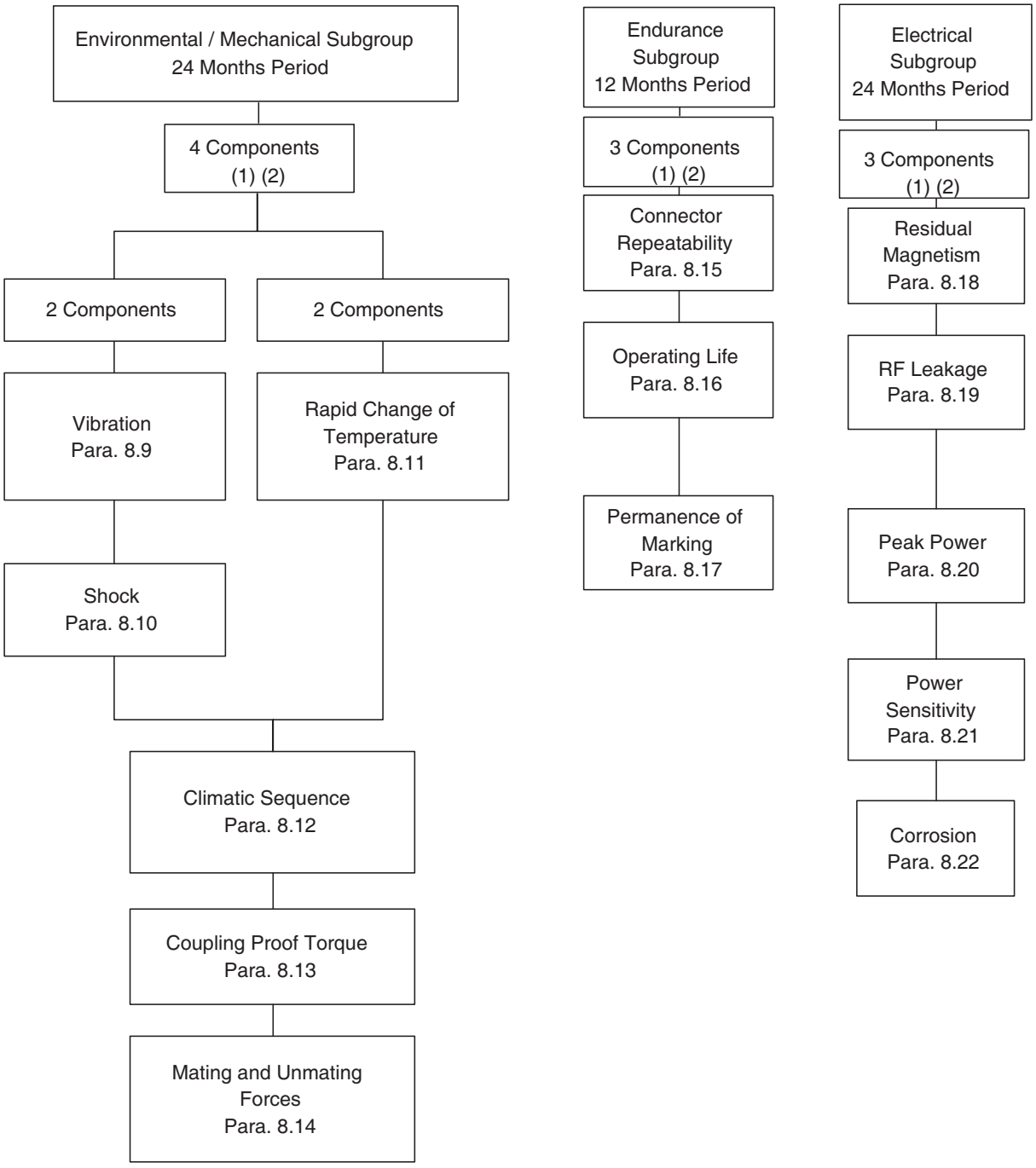
12.3 CHART F3 - SCREENING TESTS



NOTES:

1. Measurements of Parameter Drift Values need not be repeated in Room Temperature Electrical Measurements.
2. The lot failure criteria of Para. 6.4 apply to this test.
3. Check for Lot Failure shall take into account all failures that may occur during Screening Tests in accordance with Paras. 8.6.2, 8.6.3, 8.6.4, 8.1, 8.8 subsequent to Burn-in.

12.4 CHART F4 - QUALIFICATION AND PERIODIC TESTS



NOTES:

1. For distribution within the subgroups see Para. 7.1.2 for qualification and qualification maintenance and Para. 7.4 for Lot Validation Testing.
2. The number of failures allowed is 1 per subgroup but the cumulative number of failures for qualification and qualification maintenance, for all three subgroups, is also 1.